

2SK2075

Silicon N Channel MOS FET

Application

High speed power switching

Features

- Low on-resistance
- High speed switching
- Low Drive Current
- No secondary breakdown
- Suitable for Switching regulator

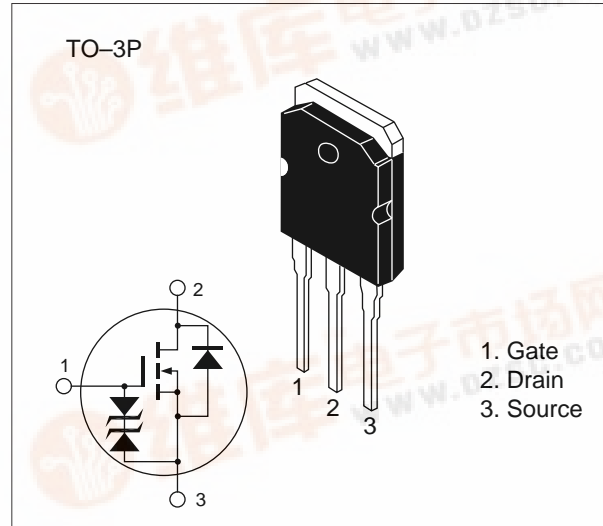


Table 1 Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	V _{DSS}	250	V
Gate to source voltage	V _{GSS}	±30	V
Drain current	I _D	20	A
Drain peak current	I _{D(pulse)} *	80	A
Body-drain diode reverse drain current	I _{DR}	20	A
Channel dissipation	P _{ch} **	100	W
Channel temperature	T _{ch}	150	°C
Storage temperature	T _{stg}	-55 to +150	°C

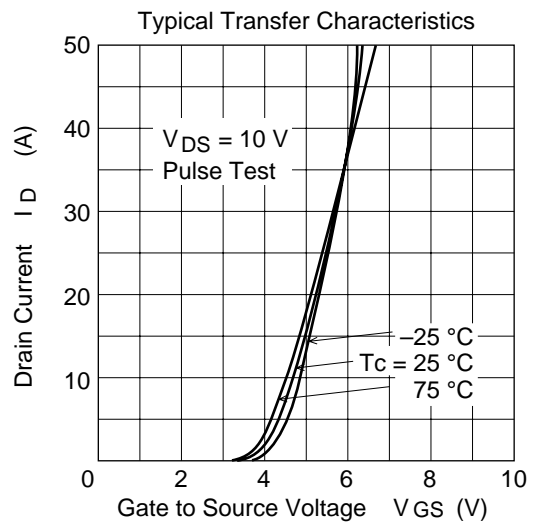
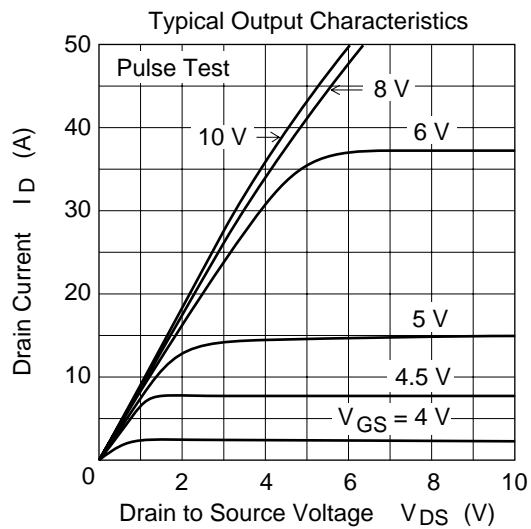
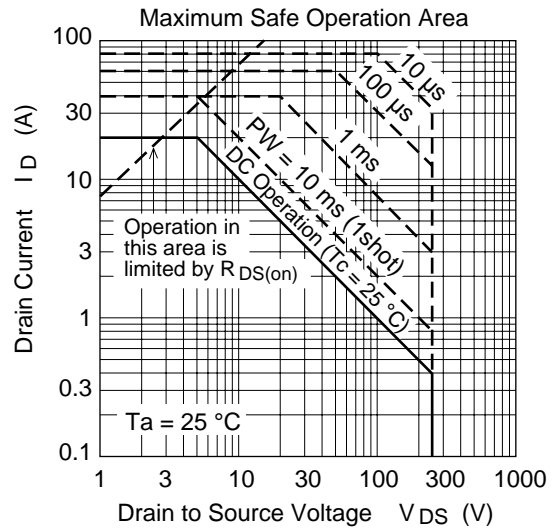
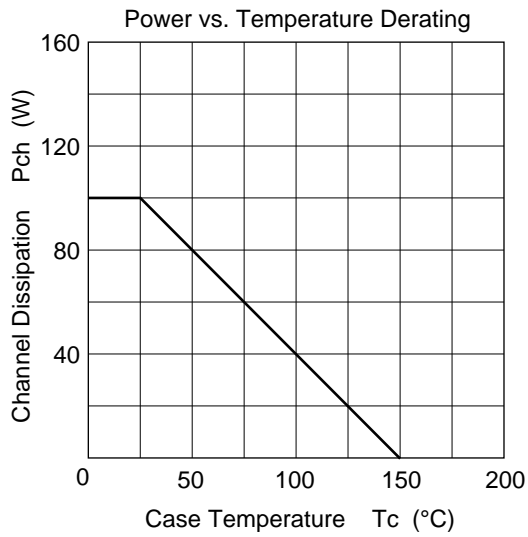
* PW ≤ 10 μs, duty cycle ≤ 1 %

** Value at Tc = 25 °C

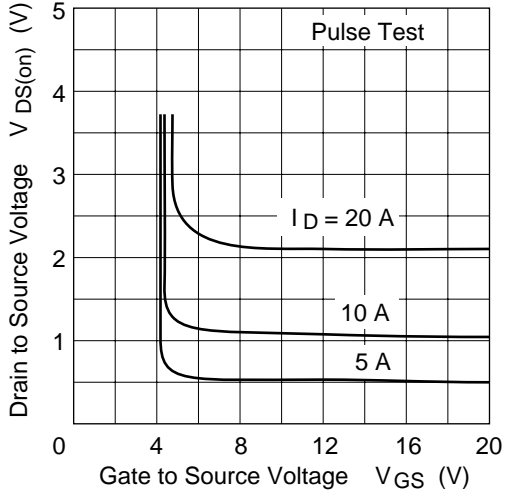
Table 2 Electrical Characteristics (Ta = 25°C)

Item	Symbol	Min	Typ	Max	Unit	Test conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	250	—	—	V	$I_D = 10 \text{ mA}$, $V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±30	—	—	V	$I_G = \pm 100 \text{ } \mu\text{A}$, $V_{DS} = 0$
Gate to source leak current	I_{GSS}	—	—	±10	μA	$V_{GS} = \pm 25 \text{ V}$, $V_{DS} = 0$
Zero gate voltage drain current	I_{DSS}	—	—	250	μA	$V_{DS} = 200 \text{ V}$, $V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	2.0	—	3.0	V	$I_D = 1 \text{ mA}$, $V_{DS} = 10 \text{ V}$
Static drain to source on state resistance	$R_{DS(on)}$	—	0.105	0.13	Ω	$I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V}^*$
Forward transfer admittance	$ y_{fs} $	9	14	—	S	$I_D = 10 \text{ A}$ $V_{DS} = 10 \text{ V}^*$
Input capacitance	C_{iss}	—	2400	—	pF	$V_{DS} = 10 \text{ V}$
Output capacitance	C_{oss}	—	970	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	C_{rss}	—	145	—	pF	$f = 1 \text{ MHz}$
Turn-on delay time	$t_{d(on)}$	—	30	—	ns	$I_D = 10 \text{ A}$
Rise time	t_r	—	110	—	ns	$V_{GS} = 10 \text{ V}$
Turn-off delay time	$t_{d(off)}$	—	220	—	ns	$R_L = 3 \text{ } \Omega$
Fall time	t_f	—	95	—	ns	
Body-drain diode forward voltage	V_{DF}	—	1.3	—	V	$I_F = 20 \text{ A}$, $V_{GS} = 0$
Body-drain diode reverse recovery time	t_{rr}	—	330	—	ns	$I_F = 20 \text{ A}$, $V_{GS} = 0$, $diF / dt = 100 \text{ A} / \mu\text{s}$

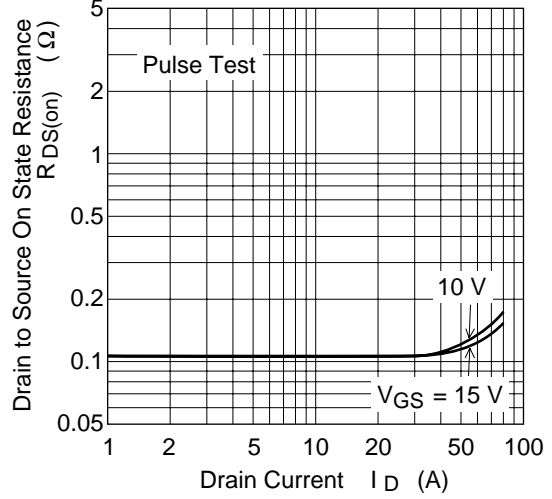
* Pulse Test



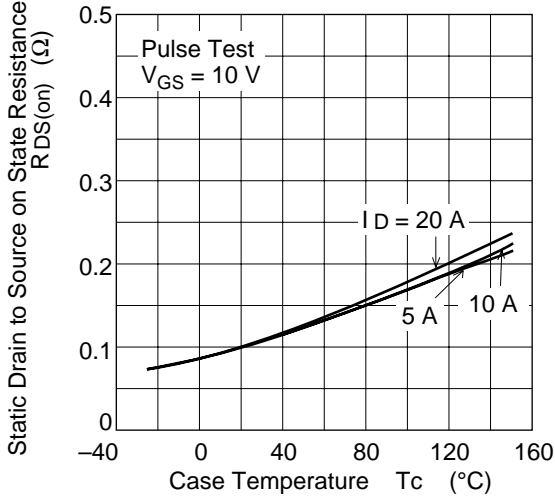
Drain to Source Saturation Voltage vs. Gate to Source Voltage



Static Drain to Source on State Resistance vs. Drain Current



Static Drain to Source on State Resistance vs. Temperature



Forward Transfer Admittance vs. Drain Current

